

Notice of References Cited	Application/Control No. 10/639,052	Applicant(s)/Patent Under Reexamination KATANO, SEIICHI	
	Examiner Tadesse Hailu	Art Unit 2173	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0184108	09-2004	Takano, Kenji	358/400
*	B	US-2004/0212823	10-2004	Chavers et al.	358/001.15
*	C	US-2002/0097262	07-2002	Iwase et al.	345/744
*	D	US-2002/0032754	03-2002	Logston et al.	709/219
*	E	US-2003/0163628	08-2003	Lin, Hao-Hsing	710/315
*	F	US-2004/0267888	12-2004	Oswald, Tommy Lee	709/206
*	G	US-2004/0205099	10-2004	Hagiwara, Takahiro	709/200
*	H	US-2004/0165212	08-2004	Hagiwara, Takahiro	358/001.15
*	I	US-2003/0149917	08-2003	Smith et al.	714/38
*	J	US-2002/0044299	04-2002	Iwase et al.	358/1.15
*	K	US-2003/0218769	11-2003	Otsuka, Naoki	358/1.14
*	L	US-2003/0011605	01-2003	Mullin, Thomas P.	345/502
*	M	US-6,735,641	05-2004	Kobayashi et al.	710/15

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/639,052	Applicant(s)/Patent Under Reexamination KATANO, SEIICHI	
	Examiner Tadesse Hailu	Art Unit 2173	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,850,253	02-2005	Bazerman et al.	715/734
*	B	US-6,993,558	01-2006	Yokokura, Hidenori	709/203
*	C	US-6,725,300	04-2004	Nagasaka et al.	710/62
*	D	US-6,133,847	10-2000	Yang, Ping-Fai	340/825.22
*	E	US-5,586,025	12-1996	Tsuji et al.	715/500
*	F	US-2004/0048621	03-2004	Takahashi et al.	455/456.3
*	G	US-2003/0195917	10-2003	Horiyama et al.	709/102
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.